Se	arc	h	No	ote	S	

Application/Con	trol N	ο.

Applicant(s)/Patent	under
Reexamination	

10/783,893

SEKI ET AL.

Examiner

Art Unit

Juan A. Torres

2611

	SEARCHED			
Class	Subclass	Date	Examiner	
375	147, 141	11/2/2006	JATM	
370	208, 335	11/2/2006	JATM	
. 370	342, 441	11/2/2006	JATM	
	,			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	, l		.,	
		•		

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST	11/2/2006	JATM
IDS Flag Clearance	11/2/2006	JATM
Inventor search	11/2/2006	JATM
Claim interference search	11/2/2006	JATM
Google	11/2/2006	JATM
Scirus	11/2/2006	JATM
IEEE	11/2/2006	MTAL
EPO	11/2/2006	JATM